imall

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High Speed IGBT in NPT-technology

- 30% lower *E*_{off} compared to previous generation
- Short circuit withstand time 10 μs
- Designed for operation above 30 kHz
- NPT-Technology for 600V applications offers:

 - parallel switching capability moderate E_{off} increase with temperature
 - very tight parameter distribution
- High ruggedness, temperature stable behaviour •
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹ for target applications •
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/

Туре	V _{CE}	I _c	E _{off}	Tj	Marking	Package
SGP20N60HS	600V	20	240µJ	150°C	G20N60HS	PG-TO-220-3-1
SGW20N60HS	600V	20	240µJ	150°C	G20N60HS	PG-TO-247-3

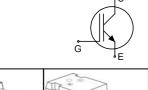
Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	600	V
DC collector current	/ _C		А
$T_{\rm C}$ = 25°C		36	
$T_{\rm C}$ = 100°C		20	
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	80	
Turn off safe operating area	-	80	
$V_{CE} \le 600 V, \ T_j \le 150^{\circ} C$			
Avalanche energy single pulse $I_{\rm C}$ = 20A, V_{CC} =50V, R_{GE} =25 Ω start T_J =25°C	E _{AS}	115	mJ
Gate-emitter voltage static transient ($t_p < 1\mu s$, $D < 0.05$)	V _{GE}	±20 ±30	V
Short circuit withstand time ²⁾	t _{sc}	10	μs
V_{GE} = 15V, $V_{\text{CC}} \le 600$ V, $T_{j} \le 150^{\circ}$ C			
Power dissipation	P _{tot}	178	W
$T_{\rm C}$ = 25°C			
Operating junction and storage temperature	T _j , T _{stg}	-55+150	°C
Time limited operating junction temperature for $t < 150h$	T _{j(tl)}	175	
Soldering temperature, 1.6mm (0.063 in.) from case for 10s	-	260	

¹ J-STD-020 and JESD-022

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.

Power Semiconductors

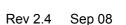


PG-TO-247-3

GCE

GCE

PG-TO-220-3-1





Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance, junction – case	R _{thJC}		0.7	K/W
Thermal resistance,	R _{thJA}	PG-TO-220-3-1	62	
junction – ambient		PG-TO-247-3-21	40	

Electrical Characteristic, at T_i = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions		Value		Unit
Parameter	Symbol Conditions		min.	Тур.	max.	onne
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE} =0V, I_{C} =500 μ A	600	-	-	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =20A				
		<i>T</i> _j =25°C		2.8	3.15	
		<i>T</i> _j =150°C		3.5	4.00	
Gate-emitter threshold voltage	V _{GE(th)}	$I_{\rm C}$ =500 μ A, $V_{\rm CE}$ = $V_{\rm GE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V, V_{GE} =0V				μA
		<i>T</i> _j =25°C	-	-	40	
		<i>T</i> _j =150°C	-	-	2500	
Gate-emitter leakage current	I _{GES}	$V_{CE} = 0V, V_{GE} = 20V$	-	-	100	nA
Transconductance	${m g}_{\sf fs}$	V _{CE} =20V, <i>I</i> _C =20A	-	14		S

Dynamic Characteristic

Input capacitance	Ciss	V _{CE} =25V,	-	1100	pF
Output capacitance	Coss	V _{GE} =0V,	-	105	
Reverse transfer capacitance	Crss	f=1MHz	-	64	
Gate charge	Q _{Gate}	V _{CC} =480V, <i>I</i> _C =20A	-	100	nC
		V _{GE} =15V			
Internal emitter inductance	LE	PG-TO-220-3-1	-	7	nH
measured 5mm (0.197 in.) from case		PG-TO-247-3-21		13	
Short circuit collector current ¹⁾	I _{C(SC)}	V_{GE} =15V, t_{SC} ≤10µs V_{CC} ≤ 600V, T_{j} ≤ 150°C	-	170	A

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



Switching Characteristic, Inductive Load, at Tj=25 °C

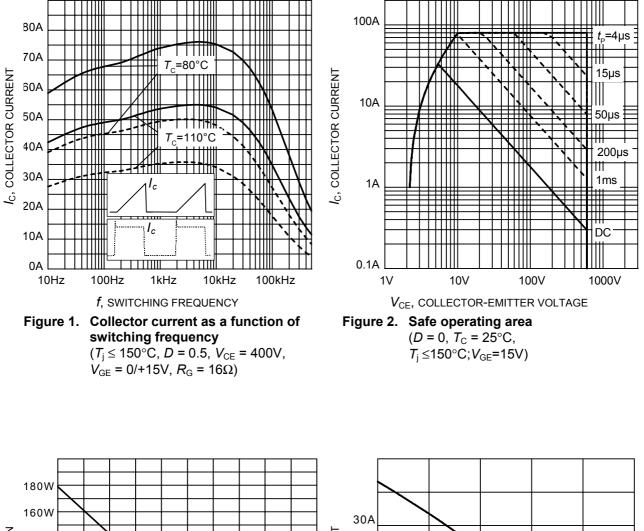
Parameter	Symbol	Conditions	Value			Unit
Farameter	Symbol	Conditions	min.	typ.	max.	
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =25°C, <i>V</i> _{CC} =400V, <i>I</i> _C =20A,	-	18		ns
Rise time	tr		-	15		
Turn-off delay time	$t_{d(off)}$	V _{GE} =0/15V, R _G =16Ω	-	207		
Fall time	t _f	$L_{\sigma}^{(1)} = 60 \text{nH},$	-	13		1
Turn-on energy	Eon	$C_{\sigma}^{(1)} = 40 \text{ pF}$ Energy losses include	-	0.39		mJ
Turn-off energy	E _{off}	"tail" and diode	-	0.30		7
Total switching energy	Ets	reverse recovery.	-	0.69		7

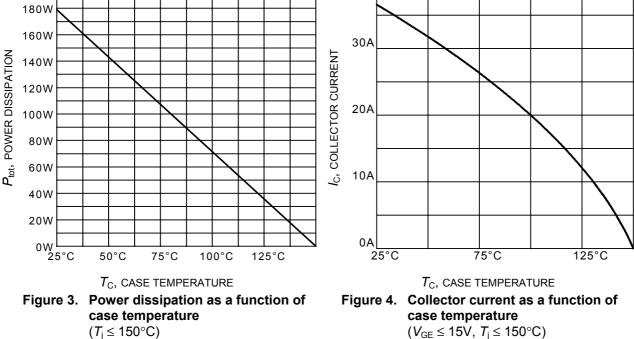
Switching Characteristic, Inductive Load, at T_j =150 °C

Paramatar	Symbol	Conditions		Value		Unit
Parameter	Symbol	Conditions	min.	typ.	max.	
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =150°C	-	15		ns
Rise time	tr	$V_{\rm CC} = 400 V, I_{\rm C} = 20 A,$	-	8.5		
Turn-off delay time	$t_{d(off)}$	V _{GE} =0/15V, R _G = 2.2Ω	-	65		
Fall time	t _f	$L_{\sigma}^{(1)}$ =60nH,	-	35		
Turn-on energy	Eon	$C_{\sigma}^{(1)} = 40 \text{ pF}$ Energy losses include	-	0.46		mJ
Turn-off energy	E _{off}	"tail" and diode	-	0.24		
Total switching energy	Ets	reverse recovery.	-	0.7		
Turn-on delay time	t _{d(on)}	<i>T</i> _j =150°C	-	17		ns
Rise time	t _r	$V_{\rm CC} = 400 V, I_{\rm C} = 20 A,$	-	13		
Turn-off delay time	$t_{d(off)}$	- V _{GE} =0/15V, R _G = 16Ω	-	222		
Fall time	t _f	$L_{\sigma}^{(1)}$ =60nH,	-	13		
Turn-on energy	Eon	$C_{\sigma}^{(1)} = 40 \text{ pF}$	-	0.6		mJ
Turn-off energy	E _{off}	Energy losses include "tail" and diode	-	0.36		
Total switching energy	E _{ts}	reverse recovery.	-	0.96		

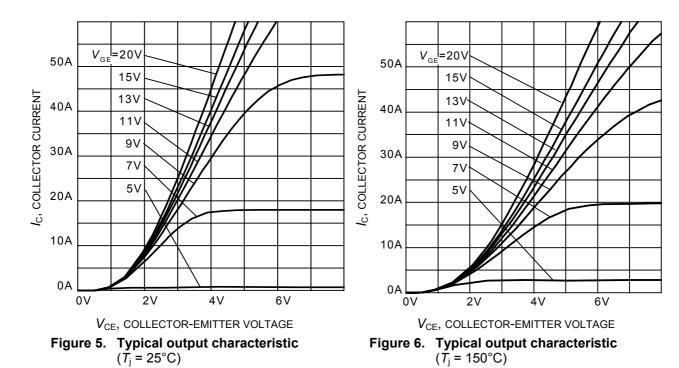
 $^{1)}$ Leakage inductance L $_{\sigma}$ and Stray capacity C $_{\sigma}$ due to test circuit in Figure E.

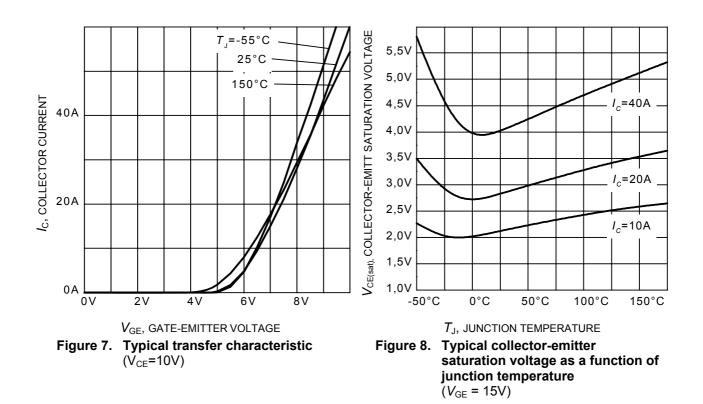






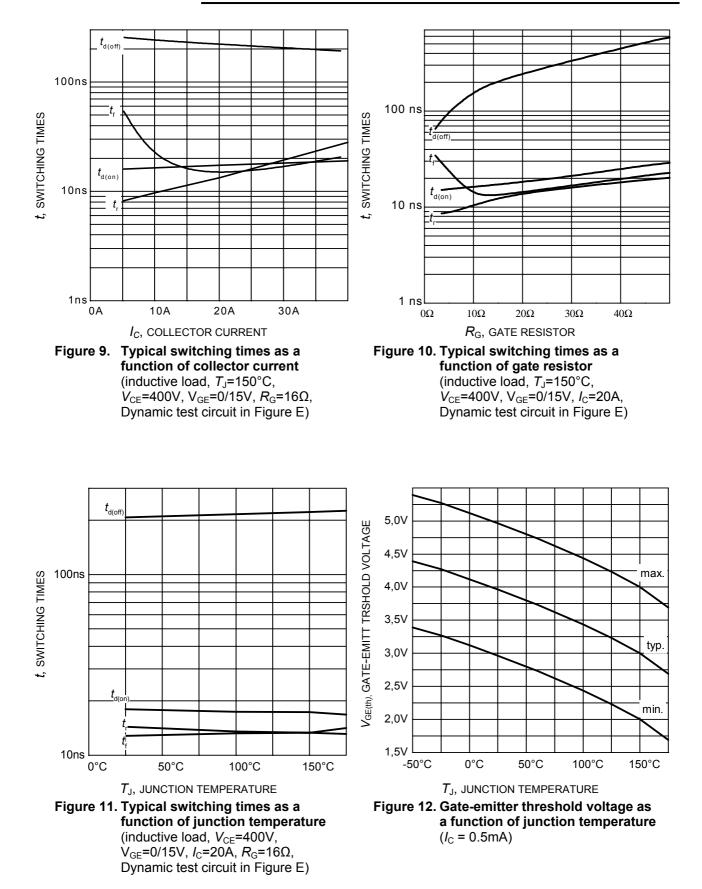






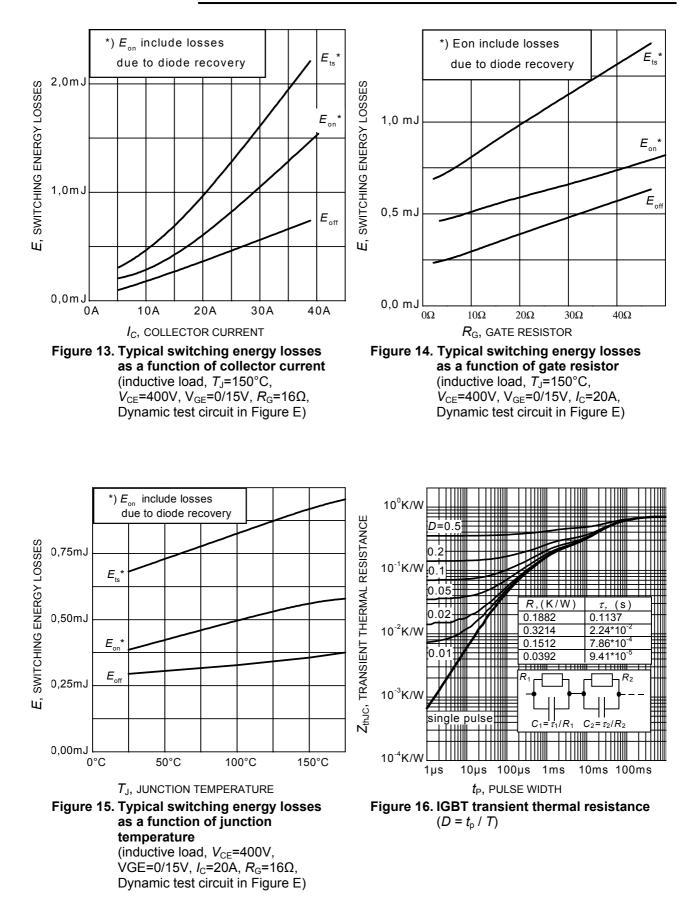
Power Semiconductors



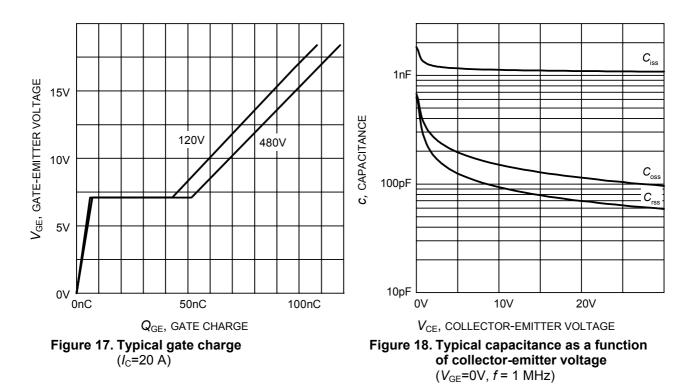


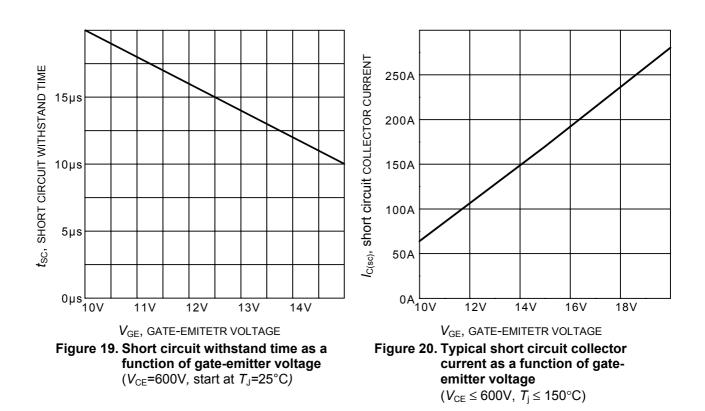
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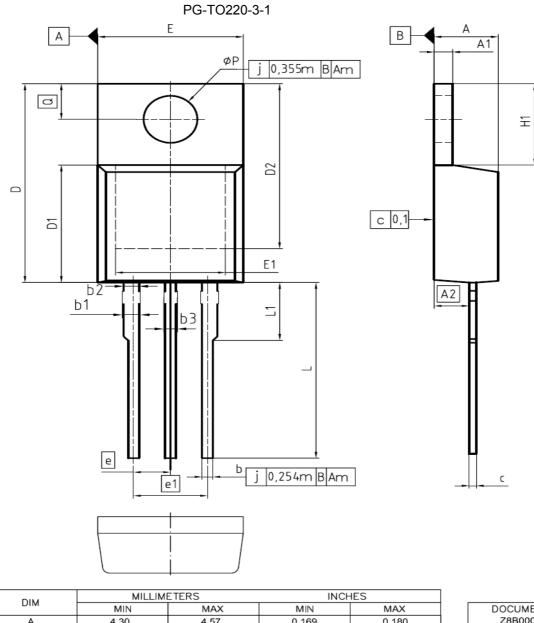




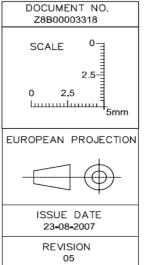








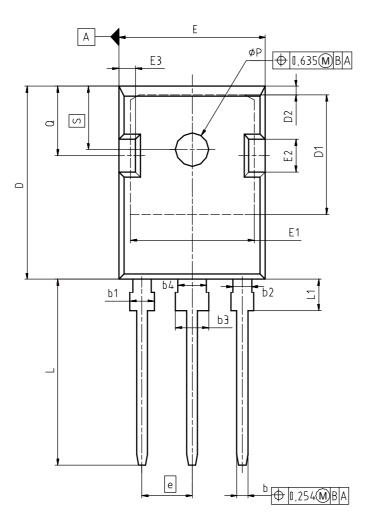
DIM	MIN	MAX	MIN	MAX		
A	4,30	4,57	0.169	0.180		
A1	1.17	1.40	0.046	0.055		
A2	2,15	2,72	0.085	0.107		
b	0.65	0.86	0.026	0.034		
b1	0.95	1.40	0.037	0.055		
b2	0.95	1.15	0.037	0.045		
b3	0.65	1,15	0.026	0.045		
с	0.33	0.60	0.013	0.024		
D	14.81	15.95	0.583	0.628		
D1	8.51	9.45	0.335	0.372		
D2	12.19	13.10	0.480	0.516		
E	9.70	10.36	0.382	0.408		
E1	6.50	8,60	0.256	0.339		
е	2.5	54	0.1	00		
e1	5.0)8	0.2	200		
N	:	3	:	3		
H1	5.90	6.90	0.232	0.272		
L	13.00	14.00	0.512	0.551		
L1	-	4,80	-	0.189		
øP	3.60	3.89	0.142	0.153		
Q	2.60	3.00	0.102	0.118		



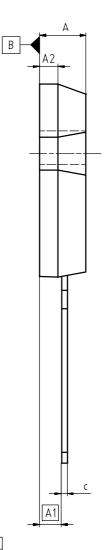
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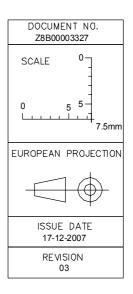


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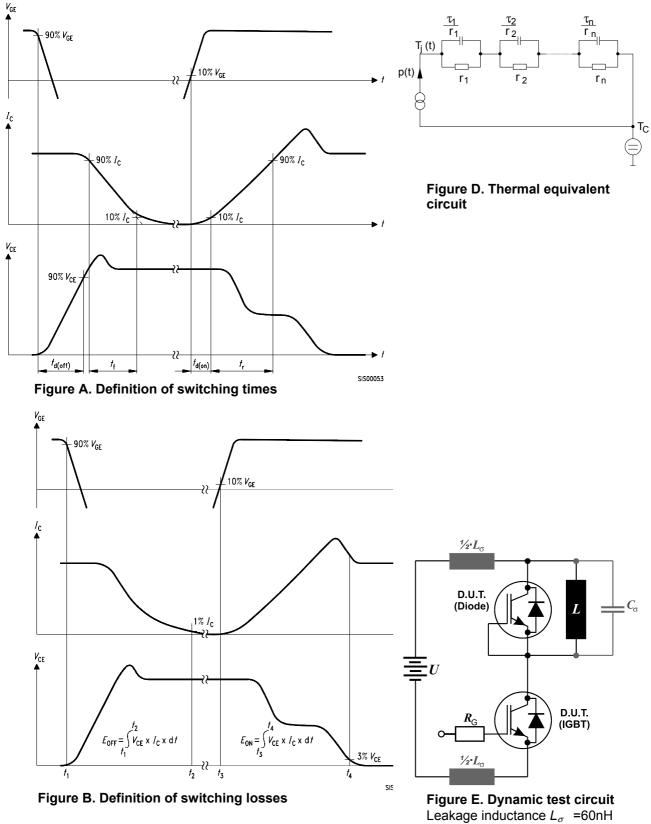


DIM	MILLIM	IETERS	INCH	IES
DIM	MIN	MAX	MIN	MAX
А	4.90	5.16	0.193	0.203
A1	2.27	2.53	0.089	0.099
A2	1.85	2.11	0.073	0.083
Ь	1.07	1.33	0.042	0.052
b1	1.90	2.41	0.075	0.095
Ь2	1.90	2.16	0.075	0.085
b3	2.87	3.38	0.113	0.133
Ь4	2.87	3.13	0.113	0.123
С	0.55	0.68	0.022	0.027
D	20.82	21.10	0.820	0.831
D1	16.25	17.65	0.640	0.695
D2	1.05	1.35	0.041	0.053
E	15.70	16.03	0.618	0.631
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.68	2.60	0.066	0.102
e	5	.44	0.2	214
N		3		3
Ĺ	19.80	20.31	0.780	0.799
L1	4.17	4.47	0.164	0.176
øP	3.50	3.70	0.138	0.146
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248









and Stray capacity C_{σ} =40pF.



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